

Notice of References Cited	Application/Control No. 10/557,517		Applicant(s)/Patent Under Reexamination FORELL, ERIK	
	Examiner Sze-Hon Kong		Art Unit 3661	Page 1 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,494,819 A	01-1985	Lidwell, Michael O.	359/356
*	B	US-5,032,775 A	07-1991	Mizuno et al.	701/25
*	C	US-5,083,256 A	01-1992	Trovato et al.	700/56
*	D	US-5,284,522 A	02-1994	Kobayashi et al.	134/18
*	E	US-5,341,540 A	08-1994	Soupert et al.	15/319
*	F	US-5,402,051 A	03-1995	Fujiwara et al.	318/587
*	G	US-5,453,931 A	09-1995	Watts, Jr., James R.	701/23
*	H	US-5,529,432 A	06-1996	Huynh et al.	404/84.05
*	I	US-5,867,800 A	02-1999	Leif, Edlund	701/23
*	J	US-5,959,423 A	09-1999	Nakanishi et al.	318/568.12
*	K	US-5,965,447 A	10-1999	Sekiyama et al.	436/49
*	L	US-5,995,884 A	11-1999	Allen et al.	701/24
*	M	US-6,039,056 A	03-2000	Verbeek, Diederik Geert	134/22.18

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/557,517		Applicant(s)/Patent Under Reexamination FORELL, ERIK	
	Examiner Sze-Hon Kong		Art Unit 3661	Page 2 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,092,010 A	07-2000	Alofs et al.	701/23
*	B	US-2002/0030742 A1	03-2002	Aman et al.	348/169
*	C	US-6,370,453 B2	04-2002	Sommer, Volker	701/23
*	D	US-6,463,368 B1	10-2002	Feiten et al.	701/23
*	E	US-2002/0189643 A1	12-2002	Chen et al.	134/6
*	F	US-6,493,613 B2	12-2002	Peless et al.	701/23
*	G	US-6,516,645 B2	02-2003	Morales et al.	72/53
*	H	US-6,539,294 B1	03-2003	Kageyama, Masato	701/23
*	I	US-2003/0146031 A1	08-2003	How, Hoton	180/167
*	J	US-6,616,244 B2	09-2003	Hakkinen, Leo	299/1.05
*	K	US-6,728,581 B1	04-2004	Trovato et al.	700/56
*	L	US-6,744,514 B2	06-2004	Kemmler et al.	356/425
*	M	US-6,836,701 B2	12-2004	McKee, Robert Nolan	700/245

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/557,517		Applicant(s)/Patent Under Reexamination FORELL, ERIK	
	Examiner Sze-Hon Kong		Art Unit 3661	Page 3 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0055142 A1	03-2005	McMurtry et al.	701/029
*	B	US-6,941,199 B1	09-2005	Bottomley et al.	701/23
*	C	US-6,957,712 B2	10-2005	Song et al.	180/167
*	D	US-7,029,199 B2	04-2006	Mayfield et al.	404/84.05
*	E	US-7,053,580 B2	05-2006	Aldred, Michael David	318/580
*	F	US-7,085,624 B2	08-2006	Aldred et al.	700/253
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.